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PIXE Induced by Medium Energy Heavy Ions in Application to Analysis of Thin Films and Subsurface Regions

Keywords

PIXE - particle induced X-ray emission, thin film, elemental composition

Topics

Interaction with Clusters, Surfaces and Solids

Primary authors: MONETA, Marek (Uniwersytet Łódzki); BOGDAN, Pawłowski (Uniwersytet Łódzki)

Presenter: MONETA, Marek (Uniwersytet Łódzki)